Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,951	KIMURA ET AL.
Examiner	Art Unit
Tianjie Chen	2627

SEARCHED				
Class	Subclass	Date	Examiner	
360	126			
	. 317			
	319	,		
29	603.15			
	603.18	11/23/2006	TJ	
•				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-			
Due				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Reports	11/23/2006	TJ	
	·		
		-	